## Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination IWAI, KAZUO

Examiner

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Art Unit

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,352,727	03-2002	Takahashi, Tetsunari	424/742
	В	US-6,554,620	04-2003	lwai, Kazuo	424/439
	O	US-2003/0100254	05-2003	lwai, Kazuo	452/173
	D	US-5,093,140	03-1992	Watanabe, Akinobu	426/326
	Е	US-5,527,492	06-1996	Hayakawa, Ritsuko	510/131
	F	US-5,696,169	12-1997	Otsu et al.	514/675
	G	US-5,968,539	10-1999	Beerse et al.	424/405
7	Н	US-6,025,312	02-2000	Saito et al.	510/130
	ı	US-6,043,287	03-2000	Nakamura, Junsuke	514/704
	J	US-6,048,836	04-2000	Romano et al.	510/490
	κ	US-6,183,748	02-2001	Tozaka, Eisaku	424/770
	L.	US-6,387,417	05-2002	Iwai, Kazuo	424/729
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z	JP 07135896 A	05-1995	Japan		A23B 04/14
	0	EP 180468 A2	05-1986	European Patent	FUKAZAWA et al.	B65D 81/24
	Ρ	JP 2002238524 A	08-2002	Japan	IWAI, KAZUO	A23L 03/3499
	a	·EP 1190715 A1	03-2002	European Patent	IWAI, KAZUO	A61K 35/78
	R	JP 02138933 A	05-1990	Japan	MORIMURA et al.	A23B 04/22
	s	JP 07327638 A	12-1995	Japan _	UNO et al.	. A23L 01/314
	Т					

## NON-PATENT DOCUMENTS

	NOTE ATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	· U							
	٧							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.